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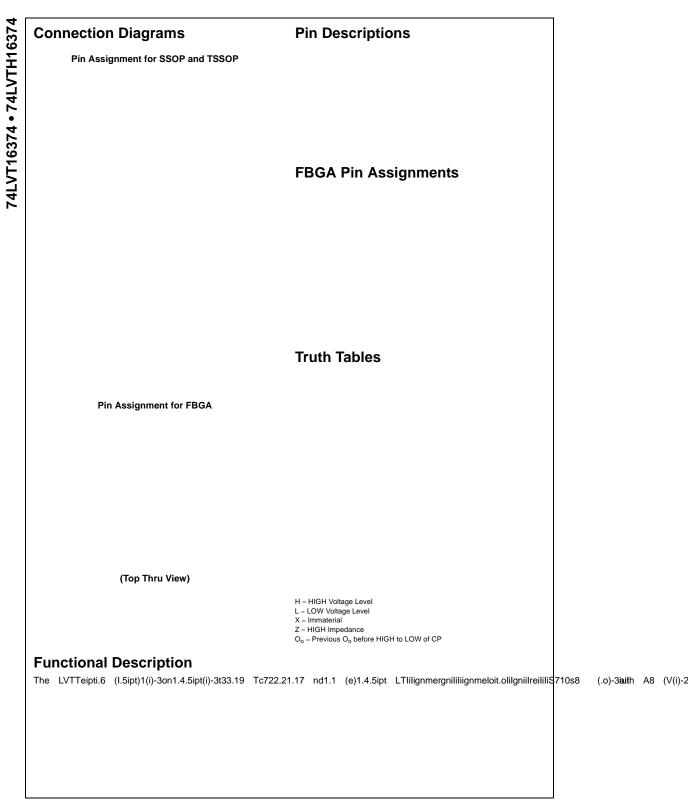
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74LVT16374 • 74LVTH16374 Low Voltage 16-Bit D-Type Flip-Flop with 3-STATE Outputs

**General Description** 

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3374	Absolute Max	ximum Ratings(No	ote 3)		
74LVT16374 • 74LVTH16374	Symbol V <sub>CC</sub>	Parameter	Value	Conditions	Units
	Recommend	ed Operating Co	nditions		
	beyond those indicated may			e device may occur. Exposure to these condition solute maximum rated conditions is not implied.	ns or conditions
	DC Electrical	Characteristics			

## DC Electrical Characteristics (Continued)

Symbol	Parameter	V <sub>cc</sub>	T <sub>A</sub> 40q	T <sub>A</sub> 40qC to 85qC		Conditions
		(V)	Min	Max	Units	Conditions
I <sub>CCH</sub>	Power Supply Current	3.6		0.19	mA	Outputs HIGH
I <sub>CCL</sub>	Power Supply Current	3.6		5	mA	Outputs LOW
I <sub>CCZ</sub>	Power Supply Current	3.6		0.19	mA	Outputs Disabled
I <sub>CCZ</sub>	Power Supply Current	3.6		0.19	mA	V <sub>CC</sub> d V <sub>O</sub> d 5.5V,
						Outputs Disabled
'l <sub>CC</sub>	Increase in Power Supply Current	3.6		6/22ND01	Tm 8(55)11m8	(//P (-1/)66 (\$ dD())519 0 2003 719c (4 nd) -08

Note 5: Applies to bushold versions only (74LVTH16374).

Note 6: An external driver must source at least the specified current to switch from LOW-to-HIGH.

Note 7: An external driver must sink at least the specified current to switch from HIGH-to-LOW.

Note 8: This is the increase in supply current for each input that is at the specified voltage level rather than  $V_{CC}$  or GND.

## Dynamic Switching Characteristics (Note 9)

Note 9: Characterized in SSOP package. Guaranteed parameter, but not tested. Note 10: Max number of outputs defined as (n). n–1 data inputs are driven 0V to 3V. Output under test held LOW.

#### **AC Electrical Characteristics**

Note 11: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW ( $t_{OSHL}$ ) or LOW-to-HIGH ( $t_{OSLH}$ ).

### Capacitance (Note 12)

Note 12: Capacitance is measured at frequency f = 1 MHz, per MIL-STD-883, Method 3012.

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